

Die Datasheet

GA01PNS150-CAU

Silicon Carbide PiN Diode Chip

 V_{RRM} = 15000 V $I_F @ 25 °C$ = 1 A

Features

- 15 kV blocking
- 210 °C operating temperature
- Fast turn off characteristics
- Soft reverse recovery characteristics
- Ultra-Fast high temperature switching







Die Size = 2.4 mm x 2.4 mm

REACH

Advantages

- Highest voltage rectifier commercially available
- Reduced stacking
- Reduced system complexity/Increased reliability

Applications

- Voltage Multiplier
- Ignition/Trigger Circuits
- Oil/Downhole
- Lighting
- Defense

Maximum Ratings at T_j = 210 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V_{RRM}		15	kV
Continuous forward current	I _F		1	Α
RMS forward current	I _{F(RMS)}		0.5	Α
Operating and storage temperature	T_{j} , T_{stg}		-55 to 210	°C

Electrical Characteristics at T_j = 210 °C, unless otherwise specified

Symbol	Conditions		Values		Unit
Syllibol	Conditions	min.	typ.	max.	Unit
V-	$I_F = 1 \text{ A}, T_j = 25 ^{\circ}\text{C}$		6.4		V
VF	I _F = 1 A, T _j = 210 °C		4.3		V
1	$V_R = 15 \text{ kV}, T_j = 25 \text{ °C}$		1	20	^
IR	$V_R = 15 \text{ kV}, T_j = 210 ^{\circ}\text{C}$			100	μΑ
O _{rr}		V	558		nC
S 11	$dI_{-}/dt = 70 \text{ A/us}$.,			
t_s	$T_{\rm c} = 210 {\rm °C}$ $V_{\rm R} = 1000$	V	< 236		ns
			22		
С			4		pF
			3		
Q_{C}	V _R = 1000 V, f = 1 MHz, T _i = 25 °	С	4.5		nC
	С	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	$\begin{array}{c} \text{min.} \\ V_F & I_F = 1 \text{ A, } T_j = 25 \text{ °C} \\ I_F = 1 \text{ A, } T_j = 210 \text{ °C} \\ \end{array}$ $\begin{array}{c} I_R & V_R = 15 \text{ kV, } T_j = 25 \text{ °C} \\ V_R = 15 \text{ kV, } T_j = 25 \text{ °C} \\ \end{array}$ $\begin{array}{c} Q_{rr} & I_F \leq I_{F,MAX} \\ dI_F/dt = 70 \text{ A/µs} \\ T_j = 210 \text{ °C} & I_F = 1.5 \text{ A} \\ \end{array}$ $\begin{array}{c} V_R = 1000 \text{ V} \\ I_F = 1.5 \text{ A} \\ \end{array}$ $\begin{array}{c} V_R = 1 \text{ V, } f = 1 \text{ MHz, } T_j = 25 \text{ °C} \\ \end{array}$ $\begin{array}{c} V_R = 1000 \text{ V, } f = 1 \text{ MHz, } T_j = 25 \text{ °C} \\ \end{array}$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$

Figures:

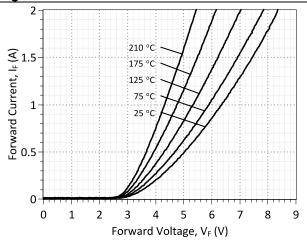


Figure 1: Typical Forward Characteristics

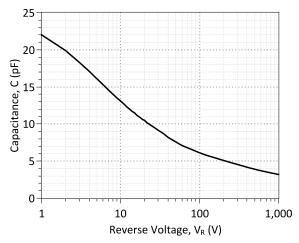


Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

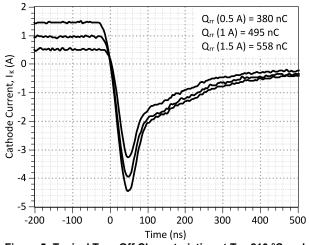


Figure 5: Typical Turn Off Characteristics at T_{j} = 210 $^{\circ}\text{C}$ and V_{R} = 1000 V

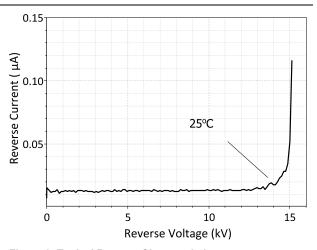


Figure 2: Typical Reverse Characteristics

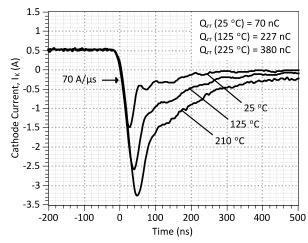


Figure 4: Typical Turn Off Characteristics at $\rm I_k$ = 0.5 A and $\rm V_R$ = 1000 V

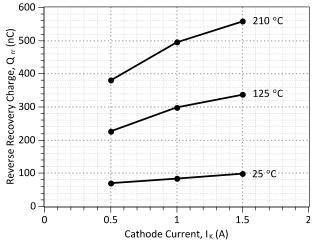


Figure 6: Reverse Recovery Charge vs Cathode Current

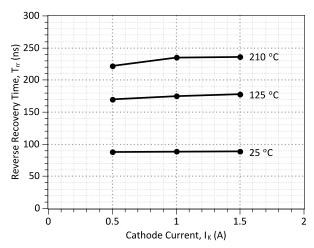


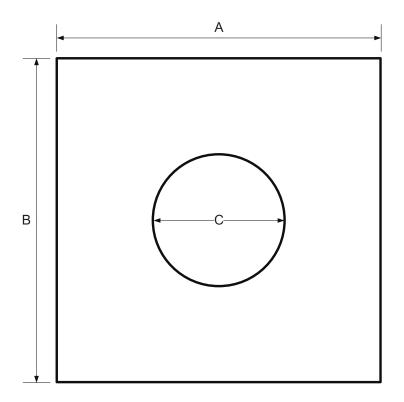
Figure 7: Reverse Recovery Time vs Cathode Current



Mechanical Parameters

Die Dimensions	2.4 x 2.4	mm ²		
Anode pad size	Ф 0.98	mm		
Area total / active	5.76/0.75	mm ²		
Die Thickness	450	μm		
Wafer Size	100	mm		
Flat Position	0	deg		
Die Frontside Passivation	Polyimide	Polyimide		
Anode Pad Metallization	400 nm Ni + 200 nm Au	400 nm Ni + 200 nm Au		
Backside Cathode Metallization	400 nm Ni + 200 nm Au	400 nm Ni + 200 nm Au		
Die Attach	Electrically conductive glue or solde	Electrically conductive glue or solder		
Wire Bond	Au ≤ 26 μm	Au ≤ 26 μm		
Reject ink dot size	Φ ≥ 0.3 mm	Φ ≥ 0.3 mm		
December ded starage environment	Store in original container, in dry nitro	Store in original container, in dry nitrogen,		
Recommended storage environment	< 6 months at an ambient temperature of	23 °C		

Chip Dimensions:



DIE	A [mm]	2.4
	B [mm]	2.4
METAL	C [mm]	0.98



Die Datasheet

GA01PNS150-CAU

Revision History				
Date	Revision	Comments	Supersedes	
2015/04/30	2	Updated Electrical Characteristics		
2015/02/25	1	Inserted Mechanical Parameters		
2014/08/26	0	Initial release		

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SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/hit_sic/baredie/pin/GA01PNS150-CAU_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GA01PNS150-CAU device.

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MODEL OF GeneSiC Semiconductor Inc.
     $Revision: 1.1
                                 $
     $Date: 30-APR-2015
                                 $
     GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
     Dulles, VA 20166
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* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
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* Models accurate up to 2 times rated drain current.
 Start of GA01PNS150-CAU SPICE Model
.MODEL GA01PNS150 D
+ IS
          9.71E-12
+ RS
          2.24770
          5.7869
+ N
          0.039646
+ IKF
+ EG
          3.23
+ XTI
          58
+ TRS1
          -0.0034
+ CJO
          2.28E-11
          2.304
+ VJ
          0.376
+ M
+ FC
          0.5
+ BV
          16000
+ IBV
          1.00E-03
+ VPK
          15000
+ IAVE
+ TYPE
          SiC PiN
+ MFG
          GeneSiC Semi
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* End of GA01PNS150-CAU SPICE Model